Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/718,317	DOVE ET AL.	
Examiner	Art Unit	
Steven S. Paik	2876	

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SEARCHED				
Class	Subclass	Date	Examiner	
235	382			
	384			
updated		12/14/2005	SSP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
same as	above	12/14/2005	SSP	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST			
Text search 235/382;384;435;375;492 340/1;10,573			
updated	12/14/2005	SSP	